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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO	
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29338 PARK LAW FI	7590 03/20/2007 RM	03/20/2007		EXAMINER	
3255 WILSHIRE BLVD			ALLISON, ANDRAE S		
SUITE 1110 LOS ANGELES, CA 90010			ART UNIT	PAPER NUMBER	
EOS MITOEBE	3, 671 70010	•	2624		
SHORTENED STATUTORY	Y PERIOD OF RESPONSE	MAIL DATE	DELIVERY MODE		
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Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)				
	10/799,399	CHA, HANBYN				
Office Action Summary	Examiner	Art Unit				
	Andrae S. Allison	2624				
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the c	correspondence address				
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DA - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. If NO period for reply is specified above, the maximum statutory period v - Failure to reply within the set or extended period for reply will, by statute. Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tir vill apply and will expire SIX (6) MONTHS from , cause the application to become AB ANDONE	N. nely filed the mailing date of this communication. D (35 U.S.C. § 133).				
Status						
1) Responsive to communication(s) filed on 12 M	arch 2004					
	action is non-final.	•				
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closed in accordance with the practice under E	•					
Disposition of Claims						
4) Claim(s) <u>1-16</u> is/are pending in the application.						
4a) Of the above claim(s) is/are withdraw	wn from consideration.					
5) Claim(s) is/are allowed.						
6)⊠ Claim(s) <u>1-16</u> is/are rejected.						
7) Claim(s) is/are objected to.						
8) Claim(s) are subject to restriction and/or	r election requirement.	•				
Application Papers		•				
9) The specification is objected to by the Examine	r.	· · · · · · · · · · · · · · · · · · ·				
10)⊠ The drawing(s) filed on <u>12 March 2004</u> is/are:		o by the Examiner.	•			
Applicant may not request that any objection to the						
Replacement drawing sheet(s) including the correct						
11) The oath or declaration is objected to by the Ex	• • • • • • • • • • • • • • • • • • • •	•				
Priority under 35 U.S.C. § 119		•				
•) (-I) (O				
12) Acknowledgment is made of a claim for foreign	priority under 35 U.S.C. § 119(a))-(a) or (1).				
a) All b) Some * c) None of:		-				
1. Certified copies of the priority documents						
2. Certified copies of the priority document		•				
3. Copies of the certified copies of the prior	•	ed in this National Stage				
application from the International Bureau	, , , ,					
* See the attached detailed Office action for a list	of the certified copies not receive	ed.	٠			
Attachment(s)	4) 🔲 Interview Summary	(PTO-413)				
1) 🔼 Notice of References Cited (P10-892) 2) 🔲 Notice of Draftsperson's Patent Drawing Review (PT0-948)	4) 🔲 Interview Summary Paper No(s)/Mail D					
3) Information Disclosure Statement(s) (PTO/SB/08)	5) 🔲 Notice of Informal F					
Paper No(s)/Mail Date <u>3/12/2004</u> .	6)					
D-44 T1 D#						

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DETAILED ACTION

Claim Objections

- 1. Claim 9 is objected to because of the following informalities:
 - a. The phrase "A system of measuring" in claim 9, line 1 should read data "A system for measuring" because the word "of" should be replaced with the word "for".

Claim Rejections - 35 USC § 102

2. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States
- 3. Claims 1-2 and 4-16 are rejected under 35 U.S.C. 102(b) as being anticipated by Hashima et al (US Patent No.: 6,115,505).

As to independent claim 1, Hashima discloses a method of measuring an object in a two-dimensional digital image (area detection method; column 1, lines 6-9), wherein the object is moved, and a first image (reference image having a predetermine pattern, column 1, lines 7) of the object, which is captured before the object is moved, and a second image (area having the same pattern; see column 1, line 7-8) of the object, which is captured after the object is moved (note that the area having the same pattern, referred to as "search image" is taken after is object is moved, see column 6, lines 45-

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55) are used in measuring, the method comprising: a) detecting two-dimensional displacement of the image by comparing the position of one reference point (e.g. mark; see column 7, line 32) of the object in the first image and the position of the same reference point of the object in the second image (see column 7, lines 50-62, where a correlator is used to used to find similarities between the reference pattern and the "search image"); and b) calculating geometrical data of the object (see column 12, lines 12-24, where the position of the reference is obtained through translation).

As to independent claim 9, this claim differs from claim 1 only in that claim 9 is a system whereas, claim 1 is method and the limitations a detection module and a calculation module calculating geometrical data of the object are additively recited. Hashima clearly teaches a system (100, see Fig) comprising: a detection module (160, area detection unit, see Fig 1) and a calculation module (140, correlator, see Fig 1) calculating geometrical data of the object.

As to claim 2, Hashima teaches the method, wherein the step of detecting twodimensional displacement comprises moving the second image so that the second image overlaps the first image (see column 14, lines 39-49, where in order to avoid erroneous detection portions of the reference and "search" images are overlapped).

As to claim 4, Hashima teaches the method, wherein the step of detecting twodimensional displacement is repeated one or more times (note that the process for

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obtaining the position is repeated; see column 12, lines 18-19).

As to claim 5, Hashima teaches the method, wherein in the step of detecting twodimensional displacement, the coordinates of one or more points of the object in the first image are memorized, wherein when the object is moved, the displacement of the object is automatically calculated (note that the position of the reference image is determined and stored, see column 7, lines 60-65)

As to claim 6, Hashima teaches the method, wherein in the step of detecting twodimensional displacement, the coordinates of one or more points of the object in the first image are memorized, wherein when the object is moved, the displacement of the object is automatically calculated within a partial range of the first image determined by a user (see Fig 4).

As to claim 7, Hashima teaches the method, wherein the geometrical data is one-dimensional, wherein the two-dimensional coordinates of a measuring point of the first image relative to the reference point, and the two-dimensional coordinates of a measuring point of the second image relative to the reference point are used in the step of calculating the geometrical data of the object (see column 9, lines 7-20)

As to claim 8, Hashima teaches the method wherein the geometrical data is twodimensional, wherein the two-dimensional coordinates of one or more measuring points

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of the first image relative to the reference point, and the two-dimensional coordinates of one or more measuring points of the second image relative to the reference point are used in the step of calculating the geometrical data of the object (see column 10, lines 17-54).

Claim 10 differ from claim 2 only in that claim 2 is a method claim whereas claim 10 is a system claim. Thus, claim 10 is analyzed as previously discussed with respect to claim 2 above.

Claims 12-16 differ from claims 4-8 only in that claims 4-8 are method claims whereas, claims 12-16 are system claims. Thus, claims 12-16 are analyzed as previously discussed with respect to claims 4-8 above.

Claim Rejections - 35 USC § 103

- 4. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 5. Claims 3 and 11 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hashima et al (US Patent No.: 6,115,505) in view of Chini et al (US Patent No.: 5,608,818).

As to claim 3, Hashima discloses the method wherein in the step of moving the second image, overlapping is determined by minimizing sum of the luminosity value of a specific point or area of the first image and the luminosity value of the same point or area of the second image (see column 3, lines 14-40), wherein the luminosity of a part of the second image, however does not expressly mention the point or area, is set to be the negative value of the luminosity of the originally captured second image.

Chini discloses an automatic pickup system (column 1, lines 6-7) that includes wherein a point or area, is set to be the negative value of the luminosity of the originally captured second image (see column 3, lines 58-61). At the time of the invention, it would have been obvious to a person of ordinary skill in the art to have modified the teaching of Hashima with the teaching of Chini to unitize an inverted image along with a reference image (see Fig 3) for detecting an object in an image by determining the coordinates of predetermined points of the detected object (column 1, lines 58-61).

Claim 11 differ from claim 3 only in that claim 3 is a method claim whereas claim 11 is a system claim. Thus, claim 11 is analyzed as previously discussed with respect to claim 3 above.

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Conclusion

The prior art made part of the record and not relied upon is considered pertinent to applicant's disclosure.

Vaidyanathan et al (US Patent No.: 5,375,177) is cited to teach a method of identifying and characterizing a valid object by color.

Surka (US Patent No.: 5,748,804) is cited to teach a method and apparatus for processing images with symbols and dense edges.

Miyagi et al (US Patent No.: 7,184,611) is cited to teach a system, method and data recording apparatus for finding an object within an image.

Beuker et al(US Patent No.:7,123,799) is cited to teach a method and apparatus for merging images into a composite image.

Gagon et al (US Patent No.: 7,027,628) is cited to teach an automated microscopic image acquisition, compositing and display.

Shilkata (US Patent No.: 7,058,221) is cited to teach a method of recognizing object based on pattern matching.

Jaggi et al (US Patent No.: 4,845,552) is cited to teach a quantitative light microscope using a solid state detector in the primary image plane

Inquires

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Andrae S. Allison whose telephone number is (571)

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270-1052. The examiner can normally be reached on Monday-Friday, 8:00 am - 5:00

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pm, EST.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Joseph Mancuso can be reached on (571) 272-7695. The fax phone number for the organization where this application or proceeding is assigned is 571-

273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

Andrae Allison

March 15, 2007

JOSEPH MANCUSO SUPERVISORY PATENT EXAMINE